

## Silicon Field Stop(FS) Trench IGBT

### Description

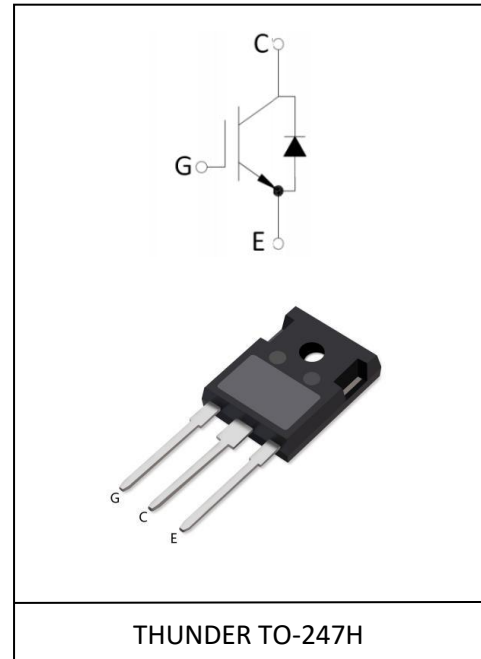
The THG75T65FQKH is use advanced field stop(FS) trench technology. The 650V FS Trench IGBT offers superior conduction and switching performances.

### General Features

- High Speed Switching & Low Power Loss
- Low saturation voltage:  $V_{CE(sat)} = 1.7V @ I_c = 75A$
- Low EMI
- Maximum junction temperature 175°C

### Application

- Solar Converters
- Welding Converters
- UPS
- PFC
- PV Inverter



### Absolute Maximum Ratings @ Tc=25°C (unless otherwise specified)

Symbol	Parameter	Value	Unit
$V_{CES}$	Collector-Emitter Voltage	650	V
$V_{GES}$	Gate-Emitter Voltage	$\pm 20$	V
$I_c$	Collector Current	150	A
	Collector Current @Tc=100°C	75	A
$I_{CM}$	Pulsed Collector Current	300	A
$I_F$	Diode Continuous Forward Current @Tc=100°C	75	A
$I_{FM}$	Diode Maximum Forward Current	300	A
$P_D$	Total Dissipation at @Tc = 25°C	438	W
	Total Dissipation at @Tc = 100°C	219	
$T_j$	Operating Junction and Storage Temperature Range	-55 to +175	°C
$T_L$	Max Temperature For Soldering	260	°C
$T_{SC}$	Short circuit data VGE=15V, VCC ≤ 360V, Tvj=150°C	5	us

**Electrical Characteristics @ T<sub>c</sub>=25°C (unless otherwise specified)**

Symbol	Parameter	Test Conditions	Min	Typ	Max	Unit
<b>Static Characteristics</b>						
V <sub>CE(S)</sub>	Collector-Emitter Voltage	V <sub>GE</sub> =0V, I <sub>CE</sub> =250μA	650	—	—	V
V <sub>CE(sat)</sub>	Collector-Emitter Saturation Voltage	V <sub>GE</sub> =15V, I <sub>C</sub> =75A T <sub>j</sub> = 25°C	—	1.90	2.4	V
V <sub>GE(th)</sub>	Gated Threshold Voltage	V <sub>CE</sub> =V <sub>GE</sub> , I <sub>C</sub> =0.5mA	4.5	5.5	6.5	V
I <sub>CE(S)</sub>	Collector-Emitter Leakage Current	V <sub>GE</sub> =0V, V <sub>CE</sub> =650V	—	—	20	uA
I <sub>GES(F)</sub>	Gate to Emitter Forward Leakage	V <sub>GE</sub> = +20V, V <sub>CE</sub> = 0V	—	—	200	nA
I <sub>GES(R)</sub>	Gate to Emitter Reverse Leakage	V <sub>GE</sub> = -20V, V <sub>CE</sub> = 0V	—	—	-200	nA
<b>Dynamic Characteristics</b>						
C <sub>ies</sub>	Input Capacitance	V <sub>GE</sub> =0V, V <sub>CE</sub> =25V, f=1.0MHZ	—	7907	—	pF
C <sub>oes</sub>	Output Capacitance		—	298	—	pF
C <sub>res</sub>	Reverse Transfer Capacitance		—	110	—	pF
Q <sub>g</sub>	Total Gate Charge	V <sub>CE</sub> =400V, I <sub>C</sub> =75A, V <sub>GE</sub> =15V	—	312	—	nC
Q <sub>ge</sub>	Gate to Emitter Charge		—	68	—	
Q <sub>gc</sub>	Gate to Collector Charge		—	129	—	
<b>Switching Characteristics</b>						
t <sub>d(on)</sub>	Turn-on Delay Time	V <sub>CE</sub> =400V, I <sub>C</sub> =75A V <sub>GE</sub> =15V, R <sub>G</sub> =10Ω	—	187	—	nS
t <sub>r</sub>	Rise Time		—	171	—	
t <sub>d(off)</sub>	Turn-off Delay Time		—	364	—	
t <sub>f</sub>	Fall Time		—	118	—	
E <sub>on</sub>	Turn-on Energy		—	9	—	mJ
E <sub>off</sub>	Turn-off Energy		—	1.7	—	
E <sub>tot</sub>	Total Switching Energy		—	10.7	—	

**Electrical Characteristics of the Diode @T<sub>c</sub>= 25°C unless otherwise specified**

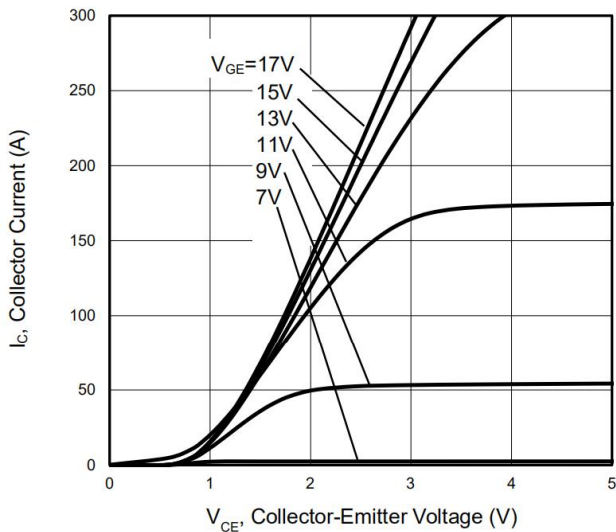
Symbol	Parameter	Test Conditions	Min	Typ	Max	Unit
I <sub>F</sub>	Diode Continuous Forward Current	T <sub>C</sub> = 100°C	75	—	—	A
I <sub>FM</sub>	Diode Maximum Forward Current		300	—	—	A
V <sub>F</sub>	Diode Forward Voltage	I <sub>F</sub> = 75A	—	1.5	2.3	V
t <sub>rr</sub>	Reverse Recovery Time	T <sub>J</sub> =25°C, I <sub>F</sub> =75A	—	41	—	nS
Q <sub>rr</sub>	Reverse Recovery Charge	di/dt=200A/us	—	0.6	—	nC
*Pulse Test: Pulse Width ≤ 300μs, Duty Cycle ≤ 2%						

### Thermal Characteristic

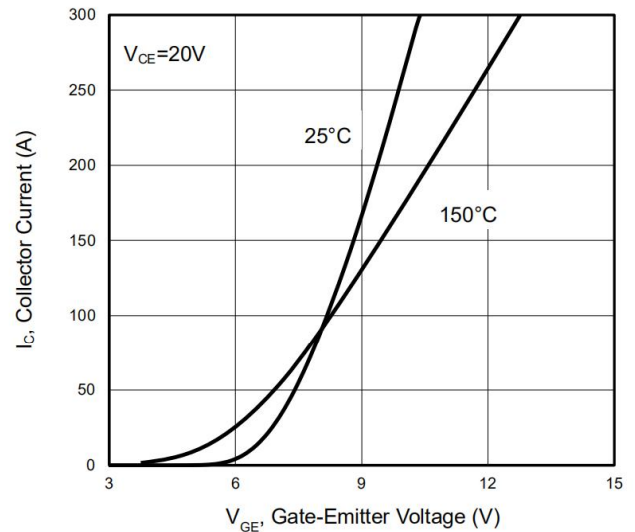
Symbol	Parameter	Typ	Max	Unit
$R_{\theta JC}$	Thermal Resistance, Junction to case for IGBT	--	0.36	$^{\circ}\text{C}/\text{W}$
$R_{\theta JC}$	Thermal Resistance, Junction to case for Diode	--	0.48	$^{\circ}\text{C}/\text{W}$
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	--	40	$^{\circ}\text{C}/\text{W}$

### Typical Performance Characteristics

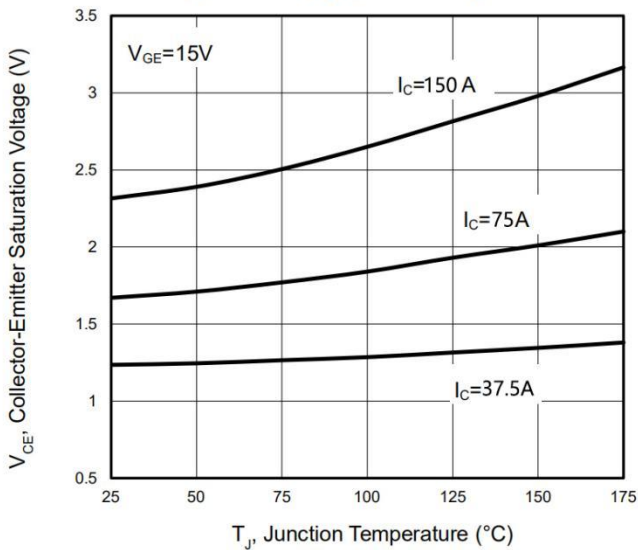
**Figure 1 Output Characteristics**



**Figure 2 Transfer Characteristics**



**Figure 3  $V_{CE(sat)}$  vs. Temperature**



**Figure 4 Saturation Voltage vs.  $V_{GE}$**

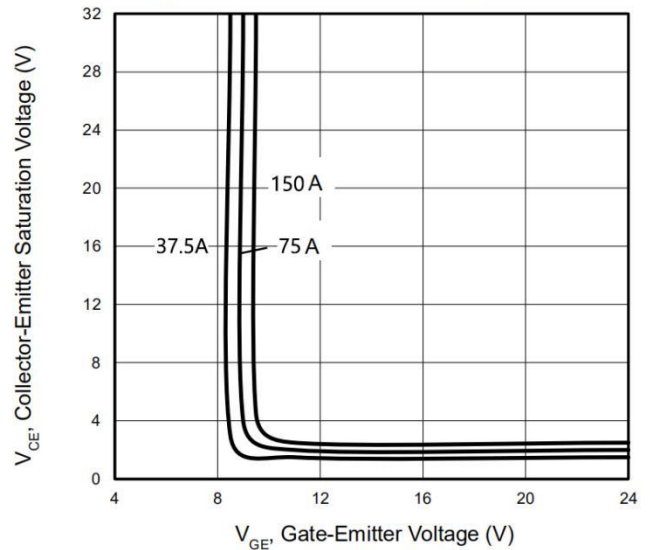


Figure 5 Capacitance Characteristics

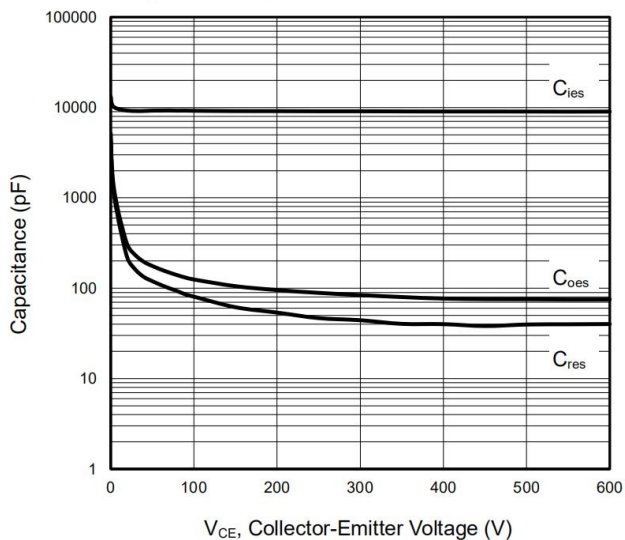


Figure 6 Gate Charge Wave Form

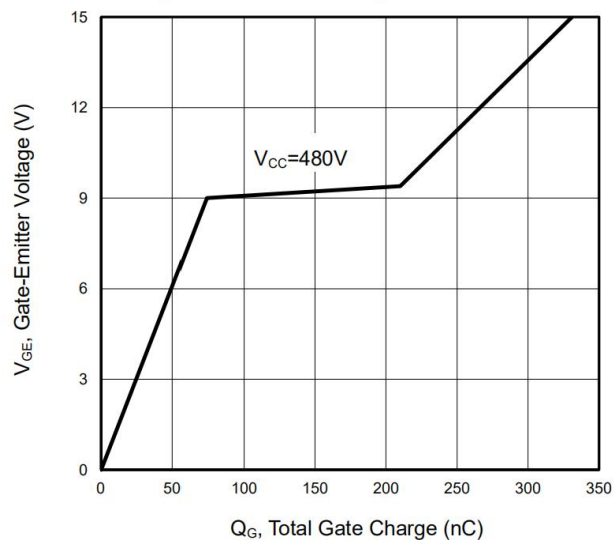


Figure 7 Forward Characteristics

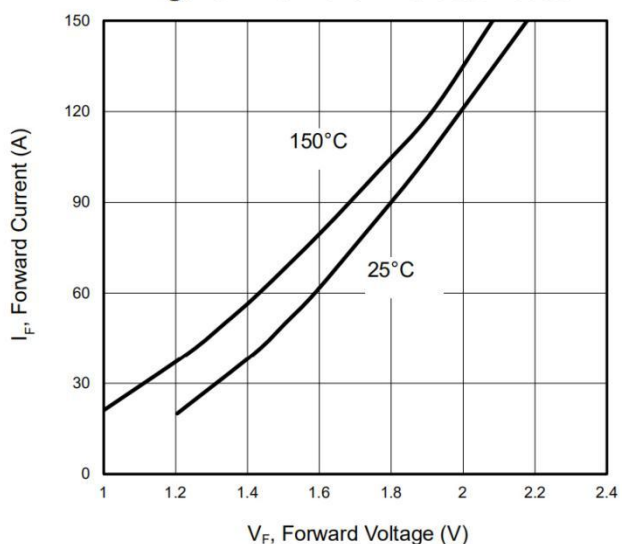


Figure 8 V\_F vs. Temperature

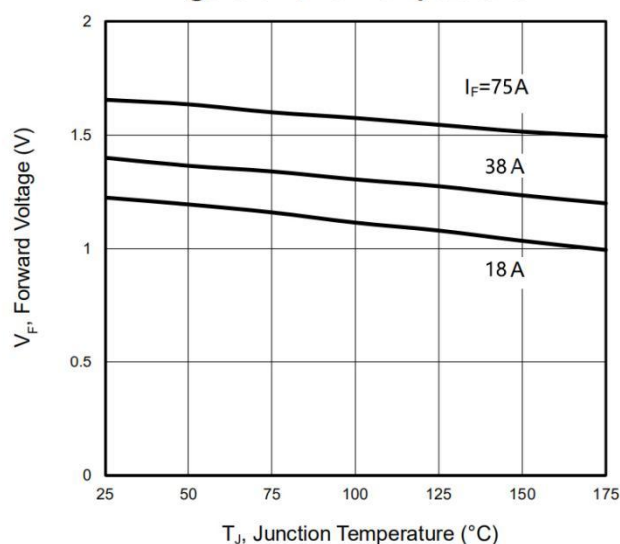


Figure 9 V\_GE(th) vs. Temperature

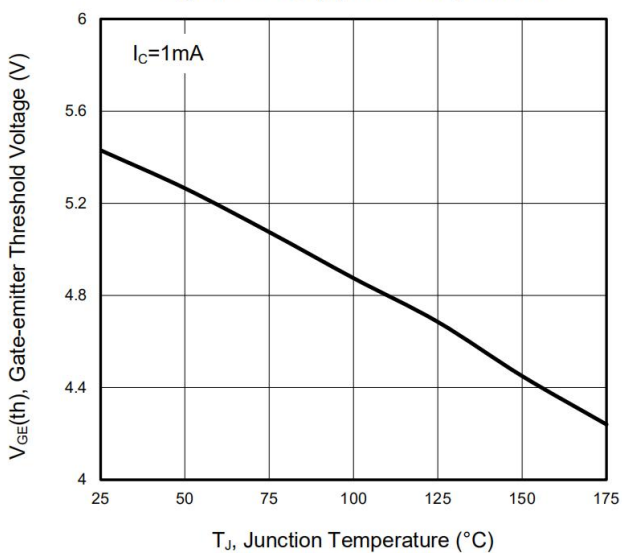
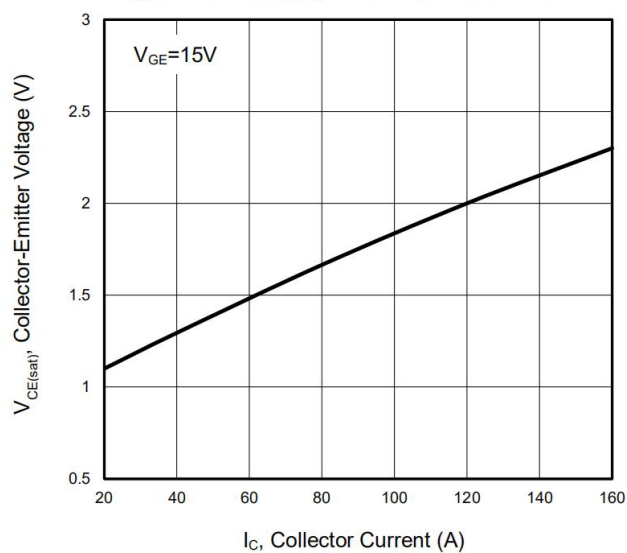
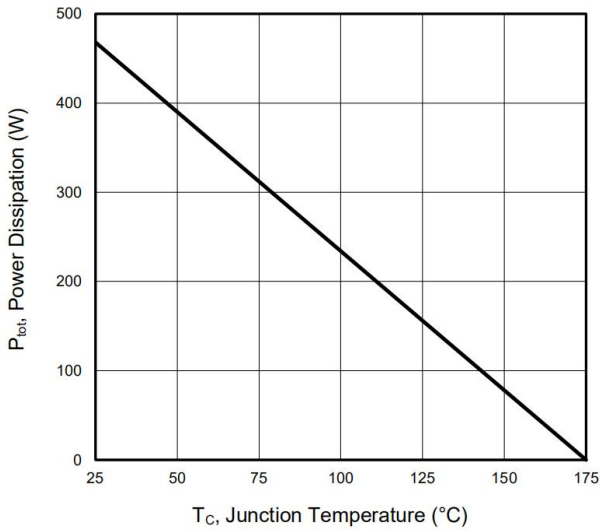


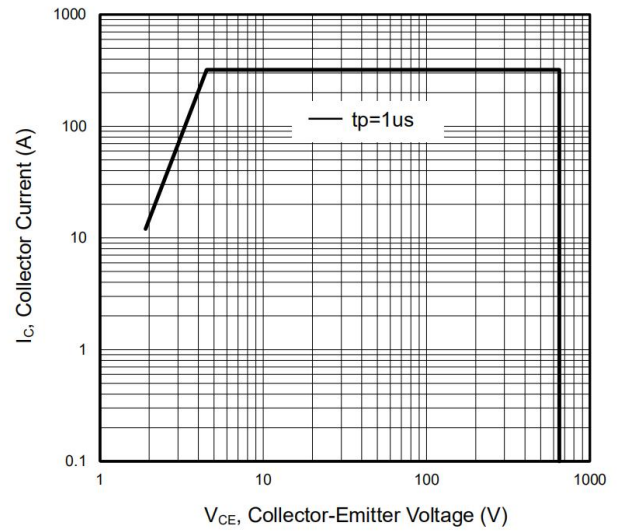
Figure 10 V\_CE(sat) vs. Collector Current



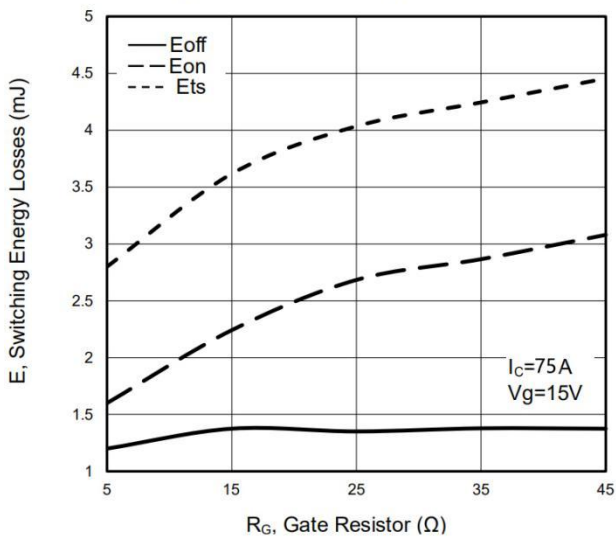
**Figure 11  $P_{tot}$  vs. Case Temperature**



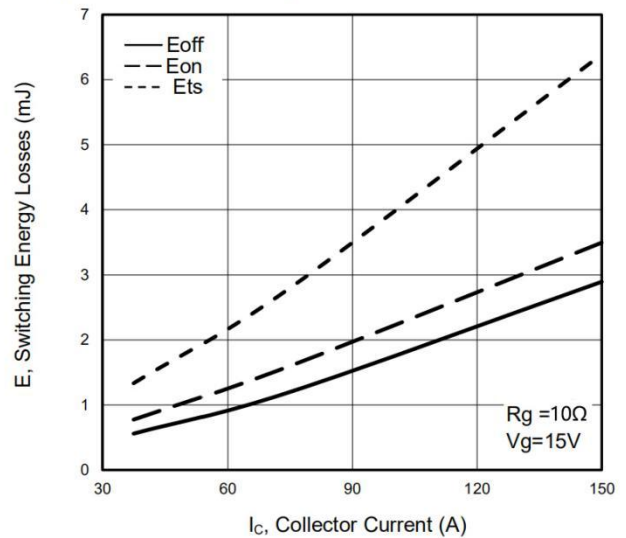
**Figure 12 Forward Bias Safe Operating Area**



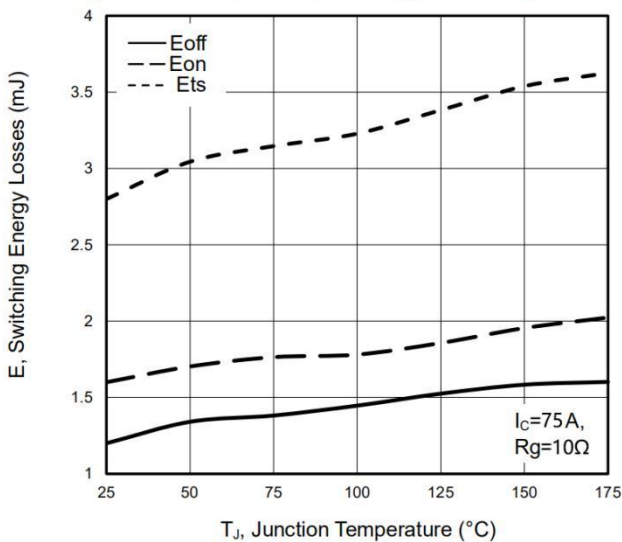
**Figure 13 Switching Loss vs.  $R_G$**



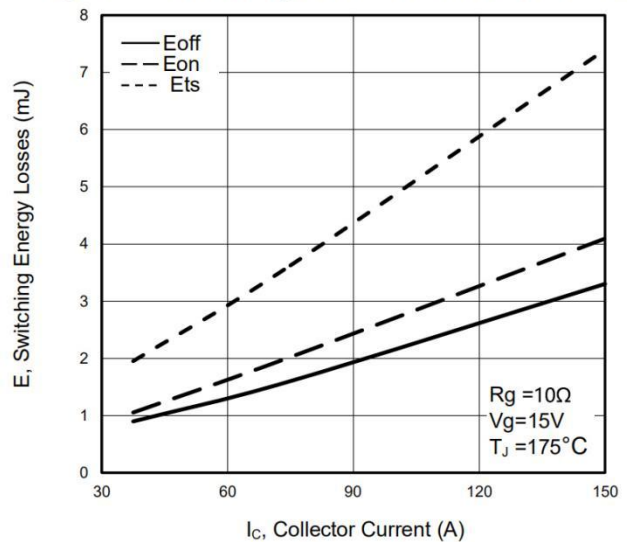
**Figure 14 Switching Loss vs. Collector Current**



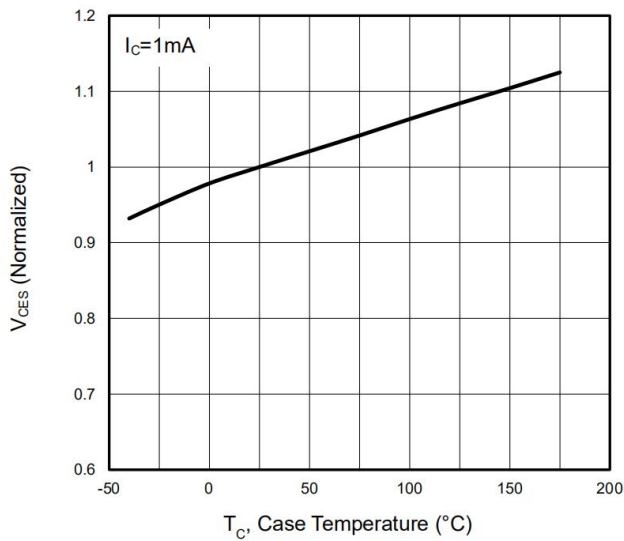
**Figure 15 Switching Energy vs. Temperature**



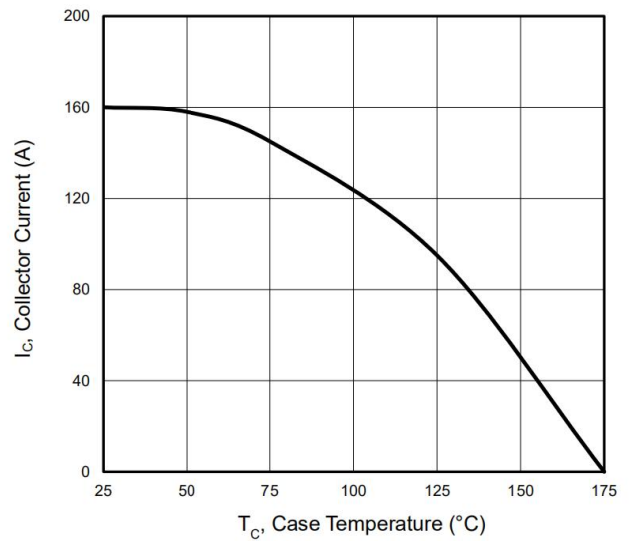
**Figure 16 Switching Loss vs. Collector Current**



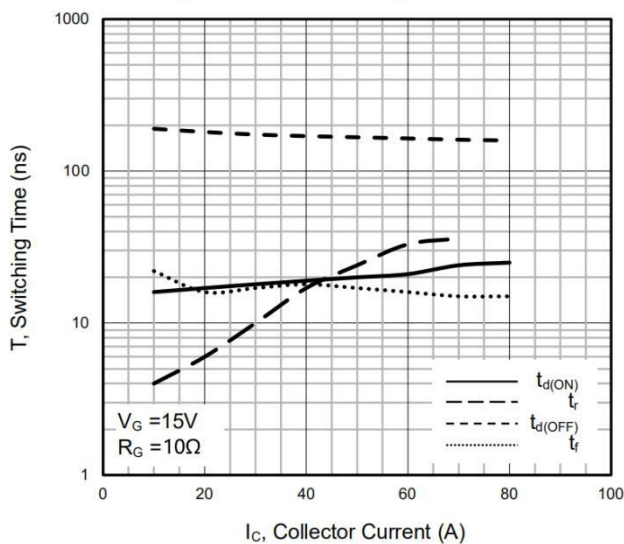
**Figure 17  $V_{CES}$  vs. Case Temperature**



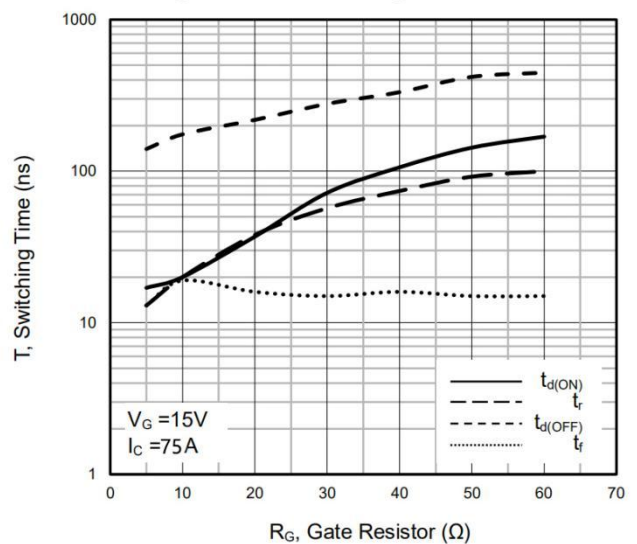
**Figure 18  $I_C$  vs. Temperature**



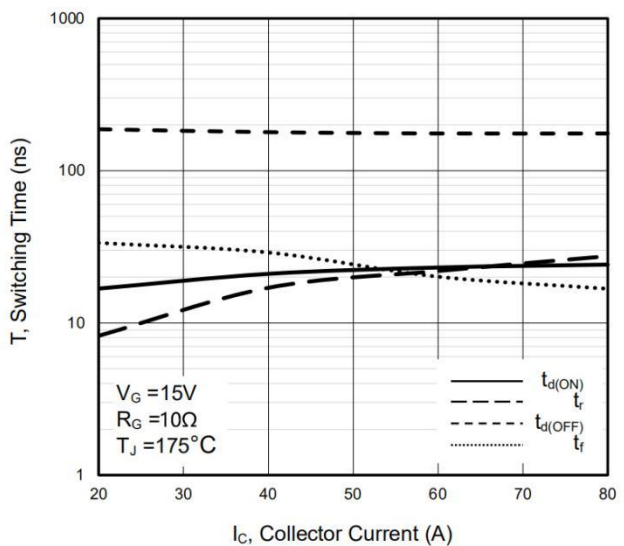
**Figure 19 Switching Time vs.  $I_C$**



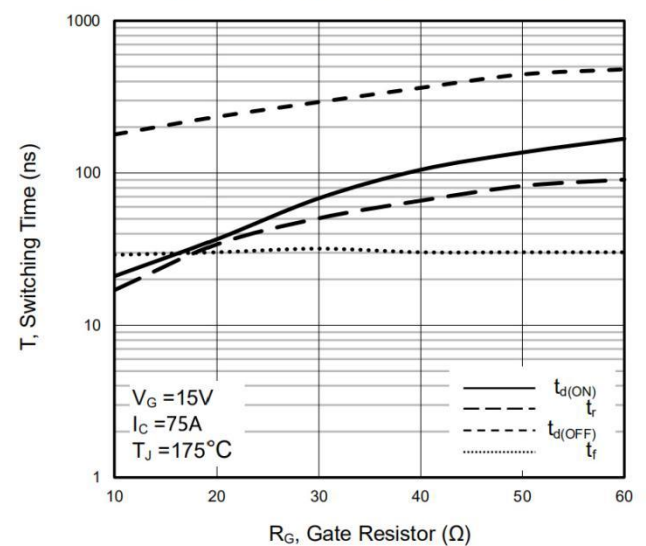
**Figure 20 Switching Time vs.  $R_G$**



**Figure 21 Switching Time vs.  $I_C$**



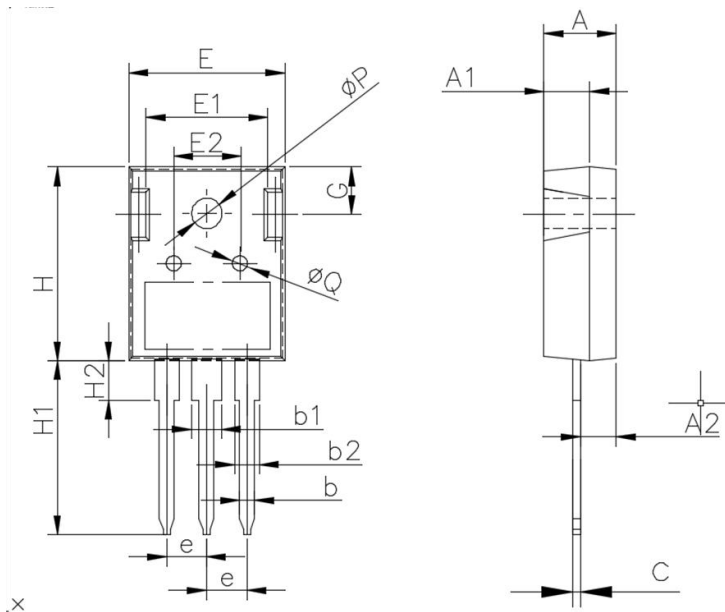
**Figure 22 Switching Time vs.  $R_G$**



## Package Information

### TO-247H PACKAGE

#### 基本尺寸



Symbol	单位 mm		
	Min	Nom	Max
A	4.80	5.00	5.20
A1	2.80	3.00	3.20
A2	2.20	2.40	2.60
b	1.05	1.20	1.35
b1	2.80	3.00	3.20
b2	1.80	2.00	2.20
c	0.50	0.60	0.70
e	5.35	5.45	5.75
E	15.6	15.80	16.0
E1	12.3	12.50	12.7
E2	6.00	6.20	6.40
H	20.8	21.0	21.2
H1	19.5	20.0	20.5
H2	3.70	4.00	4.30
G	5.70	5.90	6.10
ΦP	3.30	3.50	3.70
ΦQ	2.30	2.50	2.70

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### -Headquarters

WuXi Thunder Microelectronics Incorporated Limited

Building E1-9, No.200 LingHu Road, XinWu district, WuXi, China 214135

Tel:+86-510-85160109 Fax:+86-510-85160109